

<b>Notice of References Cited</b>	Application/Control No. 10/519,593	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Melanie D. Bissett	Art Unit 1711	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,153,038	10-1992	Koyama et al.	428/35.8
	B	US-3,768,976	10-1973	Hu et al.	422/58
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11-049919	02-1999	Japan	Nippon Synthetic	C08L 29/04
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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